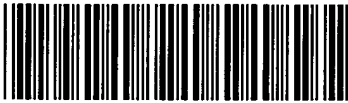


**Search Notes**

Application/Control No.

10/676,060

Examiner

Mark Ruthkosky

Applicant(s)/Patent under  
Reexamination

ARIYOSHI ET AL.

Art Unit

1745

**SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
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| Updated Search | 12/06 | MR   |
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